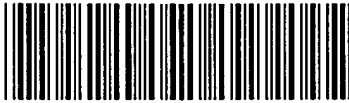


Search Notes



Application/Control No.

10/623,912

Examiner

Edward Wojciechowicz

Applicant(s)/Patent under Reexamination

CHIH ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	314	1-18-06	EH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Claims in RPUB		1-20-06	EH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Search history	1-18-06	EH